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# Reaction synthesis and characterisation of lanthanum silicon nitride

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#### **Abstract**

The synthesis of lanthanum silicon nitride (LaSi<sub>3</sub>N<sub>5</sub>) by direct nitridation of LaSi/Si/Si<sub>3</sub>N<sub>4</sub> powder mixture at 1400 °C is described. Stepwise heat treatment schedule was adopted for the synthesis of LaSi<sub>3</sub>N<sub>5</sub> powder, on the basis of TG–DTA measurements. Except temperature and nitrogen pressure also the ratio of constituents  $\text{LaSi/Si/Si}_3\text{N}_4$  has an influence on the exothermicity of the reaction and consequently on the final phase composition of the product. Silicon particle size  $d \leq 1 \mu m$  is preferable to decrease the time of nitridation. On the other hand, the reaction system must be diluted with  $Si<sub>3</sub>N<sub>4</sub>$  to avoid the overheating of powder mix and melting of silicon. When starting from binary LaSi/Si<sub>3</sub>N<sub>4</sub> powder mixture, additional nitridation at higher temperature (1550 °C) was necessary to obtain single phase LaSi<sub>3</sub>N<sub>5</sub> powder. The oxygen content of as-synthesized powders was in the range 1.0–1.2 wt%.

The lattice parameters and diffraction pattern of LaSi<sub>3</sub>N<sub>5</sub> have been calculated and compared with experimental data. The infrared spectra of  $\text{LaSi}_3\text{N}_5$  have been measured and partly described.

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Keywords: LaSi<sub>3</sub>N<sub>5</sub>; Reaction synthesis; Spectroscopy; Nitridation' powders - solid state reaction

# **1. Introduction**

Ternary nitrides have recently been widely studied, because they may display a wider variety of useful properties compared to the binary nitrides. Silicon-based ternary nitrides like  $MgSiN<sub>2</sub>$  and  $LaSi<sub>3</sub>N<sub>5</sub>$  are intensively studied as an alternative material for the substrates of the integrated circuits, $1-5$  as host lattices for light emitting phosphors,  $6-12$  semiconductors, etc. The functional properties with a combination of good strength, fracture toughness and hardness make both ternary nitrides suitable for several industrial applications. Contrary to binary nitrides ( $Mg_3N_2$  and LaN) the ternary nitrides are stable in air for long periods of time. La $Si<sub>3</sub>N<sub>5</sub>$  is resistant to aqua regia  $(HNO<sub>3</sub> + 3HCl)<sup>13</sup>$  $(HNO<sub>3</sub> + 3HCl)<sup>13</sup>$  $(HNO<sub>3</sub> + 3HCl)<sup>13</sup>$  and can be used at higher temperatures in fluorine containing environment compared to nickel alloys.<sup>[14](#page-5-0)</sup>

Several synthesis procedures have been utilized to make  $LaSi<sub>3</sub>N<sub>5</sub>$  powder. The compound has been prepared by a reaction between  $Si_3N_4$  and  $La_2O_3$  at 2000 °C under 5 MPa nitrogen

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pressure<sup>15</sup>; by hot pressing of  $Si<sub>3</sub>N<sub>4</sub>$  and LaN at 1830 °C for 1 h, under 28 MPa load<sup>14</sup>; by direct reaction of  $Si<sub>3</sub>N<sub>4</sub>$  and LaN at 1700 °C for 30 min, under 14.7 MPa nitrogen pressure<sup>16</sup>; by direct reaction of LaSi<sub>3</sub> alloys with nitrogen at 1500 °C and 0.1 MPa  $N_2$  pressure for one week<sup>13</sup>; by carbothermal reduction and nitridation (CRN) of  $La_2O_3$  and  $SiO_2$  with carbon,<sup>[17](#page-5-0)</sup> or by CRN of lanthanum acetate and tetraethoxysilane with carbon.[17,18](#page-5-0) The oxygen content varied depending on the method of preparation between 1 and 2.5 wt%.

The purpose of this work is to produce  $\text{LaSi}_3\text{N}_5$  powder from a mixture of LaSi, Si and Si3N4 starting materials with an intention to shorten the time of nitridation and make the process cost-effective.

# **2. Experimental**

Commercial powders of LaSi (Kojundo Chemical Laboratory Co., Japan), Si (99%, grain size <1 µm, Kojundo Chem. Lab. Co., Japan), and  $\alpha$ -Si<sub>3</sub>N<sub>4</sub> (grade SN-E10, Ube Industries Ltd., Japan) were used for the synthesis of  $LaSi_3N_5$  powder. The starting powder compositions were calculated according to the

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<span id="page-1-0"></span>following general reaction:

$$
LaSi + (2-3x)Si + xSi3N4 + (5/2-2x)N2 = LaSi3N5
$$
 (1)

Two different compositions have been studied in details: binary system LaSi/Si<sub>3</sub>N<sub>4</sub> (sample LSN-2, with  $x=2/3$ ) and ternary LaSi/Si/Si<sub>3</sub>N<sub>4</sub> starting mixture (sample LSN-3,  $x=0.55$ ). Owing to the partial evaporation of metals during nitridation, 5 wt% excess of LaSi was added to both mixtures.<sup>[19](#page-5-0)</sup>

The powders were mixed in  $Si<sub>3</sub>N<sub>4</sub>$  planetary ball mill in toluene for 2 h. The dried and sieved powders were placed into a BN crucible and heat-treated in an alumina-tube furnace (Koyo Thermo Systems Co., Tenri-shi, Japan) to  $1400\degree$ C with 1.5 L/min, high-purity nitrogen-gas flow.

Differential thermal analysis (DTA) and thermogravimetry (TG) were conducted up to  $1400\degree$ C (model Thermo-Plus TG 8120, Rigaku Co., Tokyo, Japan) using alumina sample holders and applying a constant heating rate of  $5^{\circ}$ C/min, in a flowing nitrogen-gas atmosphere. The phase composition of the nitrided materials was investigated by powder X-ray diffraction (Bragg-Brentano geometry and Cu K $\alpha$  radiation, model RINT2500, Rigaku Co., Japan). Precise XRD measurements were conducted also in Debye–Scherrer transmission geometry and using Co  $K\alpha$  radiation (STOE Stadi-P, Germany). The samples were rotated during measurements and the data were collected on a position-sensitive detector. The oxygen and nitrogen contents of synthesized  $\text{LaSi}_3\text{N}_5$  powders were also determined (model TC-436, LECO Co., USA).

The KBr pressed disc technique (1 mg of sample and 200 mg of KBr) was used for infrared spectroscopy. The spectra were obtained on a Nicolet Magna 750 FTIR spectrometer, equipped with an IR source and KBr beam splitter. The scans were recorded with a resolution of  $4 \text{ cm}^{-1}$ .

Structure optimizations were performed using the *ab initio* total-energy program VASP[20,21](#page-5-0) based on density functional theory (DFT). Full relaxation of all the atomic positions is performed via a conjugate-gradient algorithm.

# **3. Results and discussion**

### *3.1. Thermal analysis*

The TG–DTA curves of samples LSN-2 and LSN-3 are shown in Fig. 1. The exothermic reaction starts at  $695^{\circ}$ C in sample LSN-2 and at 710–715 °C in samples with composition LSN-3. The reaction attenuates at  $863^{\circ}$ C in both powders and accelerates again at 1185–1195 °C. The two observed exothermic reactions are most probably related to the eutectics in the La–Si binary system:  $T_E$ (La–La<sub>5</sub>Si<sub>3</sub>) = 722 ± 9 °C and  $T_E(\text{LaSi}_{2-x} - \text{Si}) = 1205 \pm 7$ °C.<sup>[22](#page-5-0)</sup> It is well known that the formation of liquid phase promotes the nitridation of silicon.[23,24](#page-5-0) On the other hand, it is necessary to avoid the local overheating of the reaction system due to the exothermic nitridation reaction. From this reason the starting mixture contained 41 vol% (LSN-3) or 49 vol% (LSN-2) of  $Si<sub>3</sub>N<sub>4</sub>$  as diluting agent and was beneficial for the production of fine homogeneous  $\text{LaSi}_3\text{N}_5$ powder. The DTA curve of sample LSN-3 shows additional



Fig. 1. TG–DTA curves of samples (a) LSN-3 and (b) LSN-2.

inflex point at  $1335-1340$  °C, followed by exothermic effect at 1360–1365  $\degree$ C. The heat was generated continuously in sample LSN-2 from 1195  $\degree$ C up to the final 1400  $\degree$ C.

The TG curves of all samples showed that the weight gain starts at ∼350 ◦C and gradually increases until the maximum temperature 1400 °C (Fig. 1). The weight gain up to  $\sim$ 1200 °C is due to the formation of LaN, which is confirmed by XRD analysis of samples nitrided up to 800, 900 and 1220 $\,^{\circ}$ C for 1 h. The phase analysis of all samples suggests the following intermediate products formation:

$$
3LaSi + N_2 \rightarrow 2LaN + LaSi2 + Si
$$
 (2a)

$$
2LaSi2 + N2 \rightarrow 2LaN + 4Si
$$
 (2b)

$$
3Si + 2N_2 \rightarrow Si_3N_4 \tag{3}
$$

and the final reaction:

$$
LaN + Si3N4 \rightarrow LaSi3N5
$$
 (4)

Reaction (2a) was confirmed by the analysis of sample LSN-2, which contained also Si and LaSi<sub>2−*x*</sub> in the product nitrided at 900 °C, although the only starting powders were LaSi and  $Si<sub>3</sub>N<sub>4</sub>$ .

<span id="page-2-0"></span>

Fig. 2. SEM micrographs of sample LSN-3.

The advantage of in situ-formed Si is the finer particle size and faster nitridation compared to the raw Si powder ( $d_{50} \le 1 \,\mu$ m, but some particles were in the range of  $10 \mu m$ ). The nitridation of silicon (both intentionally added and in situ formed) according to reaction [\(3\)](#page-1-0) is responsible for further increase of weight up to the final temperature of  $1400\,^{\circ}$ C. The simultaneous formation of LaSi<sub>3</sub>N<sub>5</sub> at temperatures  $T > 1350$  °C by reaction [\(4\)](#page-1-0) does not contribute to the weight gain. However, the formation of  $\text{La}_3\text{Si}_6\text{N}_{11}$  cannot be excluded, which might cause certain differences between the calculated and real weight gain (and nitrogen content) of the nitrided product.

## *3.2. Powder characteristics and elemental analysis*

The synthesized  $\text{LaSi}_3\text{N}_5$  powder had a light-grey colour. The morphology of unmilled powder is shown in Fig. 2. The size of agglomerates is  $2-10 \mu m$ , while the individual particle size is  $0.2-1 \mu$ m. The crystallite size determined from the half width of XRD peak intensities according to the Scherrer equation is in the range 110–140 nm.

The oxygen and nitrogen content of the analyzed samples are listed in Table 1. The nitrogen content of all samples is close to the theoretical 23.88 wt%. Slightly lower values are due to the presence of oxygen and small amount of  $La<sub>3</sub>Si<sub>6</sub>N<sub>11</sub>$  and LaSi phases. The latter might cause the greyish colour. The nitrogen content in  $\text{La}_3\text{Si}_6\text{N}_{11}$  is lower compared to  $\text{LaSi}_3\text{N}_5$ , only 20.84 wt%.

The oxygen content in both LSN samples is in correlation with the oxygen impurity in the starting powders: 1.32 wt% in  $\alpha$ -Si<sub>3</sub>N<sub>4</sub>, 1.28 wt% in Si and 0.74 wt% in LaSi, and with the fact that the nitridation was conducted in alumina tube furnace.

Table 1 Experimental and theoretical content of nitrogen and oxygen in the synthesized  $LaSi<sub>3</sub>N<sub>5</sub>$  powders



# *3.3. Phase composition*

The XRD patterns of powder products are shown in Fig. 3. Samples LSN-2a and LSN-3 were heated to 1400 ◦C. While  $LaSi<sub>3</sub>N<sub>5</sub>$  was the major phase in sample LSN-3, the intermediate products LaN and  $Si<sub>3</sub>N<sub>4</sub>$  had the strongest diffraction intensity in LSN-2a sample. La $Si<sub>3</sub>N<sub>5</sub>$  was the minor phase. By further annealing of this sample at 1550 °C for 1 h, under 0.8 MPa  $N_2$ atmosphere  $\text{LaSi}_3\text{N}_5$  powder was prepared (sample LSN-2b).

The XRD patterns of LSN-2b and LSN-3 samples are similar and the major phase is  $LaSi<sub>3</sub>N<sub>5</sub>$ . However, there were still some unidentified weak diffractions peaks. From this reason the  $XRD$  pattern of the DFT-relaxed structure of  $LaSi<sub>3</sub>N<sub>5</sub>$  has been calculated and compared with our experimental data and with Powder Diffraction File No. 42-1144. The results are shown in [Fig. 4. E](#page-3-0)xcept of weak peaks at  $2\Theta = 30.9^\circ$  and  $39.8^\circ$ , which can belong to LaSi (PDF 89-1714) and Si (PDF 35-1158), the other diffractions are from the  $LaSi<sub>3</sub>N<sub>5</sub>$  crystal planes.

The XRD results showed that from ternary  $\text{LaSi/Si/Si}_3\text{N}_4$ system nearly single phase  $\text{LaSi}_3\text{N}_5$  can be prepared by nitridation at 1400 °C, while the binary LaSi/Si<sub>3</sub>N<sub>4</sub> system should be annealed at higher temperature. Due to the exothermic character of nitridation reaction, the reason is most probably the difference



Fig. 3. XRD patterns of samples after nitridation at 1400 ◦C (LSN-2a and LSN-3) and at 1550 ◦C (LSN-2b).

<span id="page-3-0"></span>

Fig. 4. Comparison of the experimental XRD pattern of  $\text{LaSi}_3\text{N}_5$  (sample LSN-2b) with the calculated XRD profile and PDF 42-1144 of  $\text{LaSi}_3\text{N}_5$ .

in the generated heat by reaction

$$
LaSi + (2-3x)Si + xSi3N4 + (5/2-2x)N2 = LaN + Si3N4
$$
\n(5)

for  $x = 0.55$  (ternary system) and  $x = 2/3$  (binary system). The enthalpies of reaction for both *x* values are shown in Fig. 5. The standard enthalpy of formation  $\Delta H^\circ_f$  (LaSi) = −73.9 kJ mol<sup>-1</sup> was taken from Meschel et al.,  $^{25}$  $^{25}$  $^{25}$  and the temperature function  $H^{\circ}(T) - H^{\circ}$  (298 K) from Bolgar et al.<sup>26</sup> The other thermo-dynamic data are from JANAF Thermochemical Tables<sup>[27](#page-5-0)</sup> and MALT2 database. The results show that the exothermic character of reaction for ternary system is higher (more negative). The evolved heat can support the formation of  $\text{LaSi}_3\text{N}_5$  according to reaction [\(4\),](#page-1-0) while for binary system additional external heat is necessary to complete the reaction.

#### *3.4. Infrared spectroscopy*

Owing to the presence of amorphous hump in the XRD pattern of sample LSN-2a, the nitrided products have been analyzed



Fig. 5. Enthalpies of reactions for *x* values 0.55 and 0.667 in reaction (5). The ternary LaSi/Si/Si<sub>3</sub>N<sub>4</sub> system yields more exothermic reaction.



Fig. 6. Infrared spectra of (a) sample LSN-2a and commercial Ube SN-E10  $\alpha$ - $Si<sub>3</sub>N<sub>4</sub>$  powder, (b) samples LSN-2b and LSN-3 (both have La $Si<sub>3</sub>N<sub>5</sub>$  crystalline phase composition).

also by infrared (FTIR) spectroscopy. The room temperature FTIR absorption spectra are shown in Fig. 6. The IR spectrum of LSN-2a sample resembles that of  $\alpha$ -Si<sub>3</sub>N<sub>4</sub> (commercial Ube SN-E10; measured in lab), which is also shown for the comparison in Fig. 6a. The majority of the bands belong to Si-N stretching and bending/rocking vibrations and their positions are in agreement with the published data for  $\alpha$ -Si<sub>3</sub>N<sub>4</sub> ([Table 2\).](#page-4-0)<sup>[28–31](#page-5-0)</sup> In addition to Si<sub>3</sub>N<sub>4</sub> bands a broad absorption near  $720 \text{ cm}^{-1}$  appears in the spectrum of the sample LSN-2a. This band may indicate the creation of the La-N bonds.

The FTIR spectra of  $LaSi<sub>3</sub>N<sub>5</sub>$  powders (samples LSN-2b and LSN-3 in Fig. 6b) are different from that of LSN-2a sample. While a broad band near 960 cm−<sup>1</sup> and several peaks in the 900–850 cm−<sup>1</sup> region dominates in the spectrum of LSN-2a, the shape of the  $LaSi<sub>3</sub>N<sub>5</sub>$  spectrum is more complicated. Lot of well-resolved bands indicates pronounced variability in the bonding configuration in  $LaSi<sub>3</sub>N<sub>5</sub>$ , clearly different from that of LSN-2a. Majority of the bands in the  $LaSi<sub>3</sub>N<sub>5</sub>$  spectrum, i.e. bands in the 1000–800 cm<sup>-1</sup> region and below  $500 \text{ cm}^{-1}$ belong to Si-N vibrations [\(Table 2\).](#page-4-0) However, different inten-

<span id="page-4-0"></span>



Grade Ube SN-E10.

 $<sup>b</sup>$  Wada et al.<sup>28</sup>.</sup>

<sup>c</sup> Kislyj et al.[29.](#page-5-0)

 $d$  Nyquist et al.<sup>30</sup>.

<sup>e</sup> Andrievskij et al.<sup>31</sup>.

<sup>f</sup> Broad band.

sities and positions of the bands when compared to  $\alpha$ -Si<sub>3</sub>N<sub>4</sub> suggest diverse environment of the Si-N bonds. Moreover, a strong absorption band at  $1178 \text{ cm}^{-1}$  together with intensive absorption in the  $800-500$  cm<sup>-1</sup> region is seen only in the spectrum of  $LaSi<sub>3</sub>N<sub>5</sub>$ . The assignment of the individual bands is not clear yet, but it is supposed that these new bands are connected with both, vibrations of Si-N bonds in structural arrangement characteristic for  $\text{LaSi}_3\text{N}_5$ , and with vibrations of the bonds in which La atoms are involved, e.g.  $La-N$ . Inoue<sup>[16](#page-5-0)</sup> has already reported that there are two types of nitrogen environments in  $LaSi<sub>3</sub>N<sub>5</sub>$ : (i) the first type nitrogen is surrounded by three silicons in a coordination similar to  $\alpha$ -Si<sub>3</sub>N<sub>4</sub>, (ii) the second type nitrogen is surrounded by two silicon and two lanthanum atoms.

#### *3.5. Lattice parameters*

To calculate the lattice parameters of crystalline  $\text{LaSi}_3\text{N}_5$  precise XRD measurements of sample LSN-3 were carried out on STOE Stadi-P equipment with position-sensitive detector (Debye–Scherrer transmission geometry, Co K $\alpha$  radiation). The measurement conditions were: step 0.010◦; rate 0.15◦/min, in the range  $2\Theta = 20^{\circ} - 70^{\circ}$ . The results are summarized in Table 3

together with the published lattice parameters, $13,15,18$  and values calculated in this work from the optimized structure of LaSi3N5.

The experimental lattice parameters (sample LSN-3) are close to the values reported by Woike and Jeitschko.<sup>[13](#page-5-0)</sup> Slightly higher values of calculated lattice parameters are a consequence of the use of the GGA approach to the functional for the exchange and correlation of electrons. While local density approximation (LDA) leads to too short lattice parameters, the semi-local GGA leads to slightly longer lattice vectors, usually closer to experimental values. The differences in experimental results can be caused by the residual oxygen in the evaluated samples

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Experimental and calculated lattice parameters of  $LaSi<sub>3</sub>N<sub>5</sub>$  (space group  $P2_12_12_1$ .



<span id="page-5-0"></span>[\(Table 1\).](#page-2-0) It has already been shown in our previous papers  $34,35$ that the O/N substitution cause a local expansion of the structure.

## **4. Conclusions**

Almost single phase  $LaSi<sub>3</sub>N<sub>5</sub>$  powder was obtained by direct nitridation of Si/LaSi/Si<sub>3</sub>N<sub>4</sub> powder mixture. Stepwise heat treatment schedule up to  $1400\degree\text{C}$  in flowing nitrogen atmosphere was adopted for the synthesis of  $LaSi<sub>3</sub>N<sub>5</sub>$  powder, on the basis of TG–DTA measurements. The ratio of constituents Si/LaSi/Si<sub>3</sub>N<sub>4</sub> had an influence on the exothermicity of the reaction and consequently on the final phase composition of the products. When starting from binary  $\text{LaSi/Si}_3\text{N}_4$  powder mixture, additional nitridation at higher temperature (1550 $\degree$ C) was necessary to obtain single phase  $\text{LaSi}_3\text{N}_5$  powder.

Additionally, the lattice parameters and diffraction patterns have been calculated and the infrared spectra of  $\text{LaSi}_3\text{N}_5$  have been measured and partly described.

Although the oxygen content of as-synthesized powders was in the range  $1.0-1.2$  wt%, the synthesis method allows to obtain lower oxygen level. The in situ preparation of LaN and the part of  $Si<sub>3</sub>N<sub>4</sub>$  is advantageous, because the in situ-formed binary nitrides are not exposed to oxygen or humidity before the final reaction yielding ternary  $\text{LaSi}_3\text{N}_5$ .

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